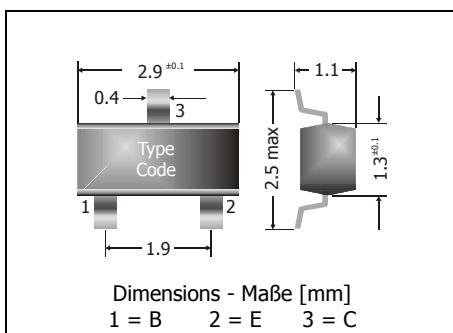


BC846 ... BC850
NPN
Surface Mount General Purpose Si-Epi-Planar Transistors
Si-Epi-Planar Universaltransistoren für die Oberflächenmontage
NPN

Version 2012-01-02



Power dissipation – Verlustleistung

250 mW

Plastic case

SOT-23

Kunststoffgehäuse

(TO-236)

Weight approx. – Gewicht ca.

0.01 g

Plastic material has UL classification 94V-0
Gehäusematerial UL94V-0 klassifiziertStandard packaging taped and reeled
Standard Lieferform gegurtet auf Rolle**Maximum ratings ($T_A = 25^\circ\text{C}$)****Grenzwerte ($T_A = 25^\circ\text{C}$)**

			BC846	BC847	BC850	BC848 BC849
Collector-Emitter-volt. – Kollektor-Emitter-Spannung	B open	V_{CEO}	65 V	45 V	45 V	30 V
Collector-Base-voltage – Kollektor-Basis-Spannung	E open	V_{CBO}	80 V	50 V	50 V	30 V
Emitter-Base-voltage – Emitter-Basis-Spannung	C open	V_{EBO}		6 V		5 V
Power dissipation – Verlustleistung		P_{tot}		250 mW ¹⁾		
Collector current – Kollektorstrom (dc)	I_C			100 mA		
Peak Collector current – Kollektor-Spitzenstrom	I_{CM}			200 mA		
Junction temperature – Sperrsichttemperatur	T_j			-55...+150°C		
Storage temperature – Lagerungstemperatur	T_s			-55...+150°C		

Characteristics ($T_j = 25^\circ\text{C}$)**Kennwerte ($T_j = 25^\circ\text{C}$)**

		Min.	Typ.	Max.
DC current gain – Kollektor-Basis-Stromverhältnis				
$V_{CE} = 5 \text{ V}, I_C = 10 \mu\text{A}$	Group A h_{FE} Group B h_{FE} Group C h_{FE}	– – –	90 150 270	– – –
$V_{CE} = 5 \text{ V}, I_C = 2 \text{ mA}$	Group A h_{FE} Group B h_{FE} Group C h_{FE}	110 200 420	180 290 520	220 450 800
Collector-Emitter saturation voltage – Kollektor-Sättigungsspannung ²⁾				
$I_C = 10 \text{ mA}, I_B = 0.5 \text{ mA}$ $I_C = 100 \text{ mA}, I_B = 5 \text{ mA}$	V_{CEsat} V_{CEsat}	– –	90 mV 200 mV	250 mV 600 mV
Base-Emitter saturation voltage – Basis-Sättigungsspannung ²⁾				
$I_C = 10 \text{ mA}, I_B = 0.5 \text{ mA}$ $I_C = 100 \text{ mA}, I_B = 5 \text{ mA}$	V_{BEsat} V_{BEsat}	– –	700 mV 900 mV	– –

1 Mounted on P.C. board with 3 mm² copper pad at each terminal
Montage auf Leiterplatte mit 3 mm² Kupferbelag (Lötpad) an jedem Anschluss

2 Tested with pulses $t_p = 300 \mu\text{s}$, duty cycle $\leq 2\%$ – Gemessen mit Impulsen $t_p = 300 \mu\text{s}$, Schaltverhältnis $\leq 2\%$

Characteristics ($T_j = 25^\circ\text{C}$)**Kennwerte ($T_j = 25^\circ\text{C}$)**

		Min.	Typ.	Max.
Base-Emitter-voltage – Basis-Emitter-Spannung ²⁾				
$V_{CE} = 5 \text{ V}, I_C = 2 \text{ mA}$ $V_{CE} = 5 \text{ V}, I_C = 10 \text{ mA}$	V_{BE} V_{BE}	580 mV –	660 mV –	700 mV 720 mV
Collector-Base cutoff current – Kollektor-Basis-Reststrom				
$V_{CB} = 30 \text{ V}, (\text{E open})$ $V_{CE} = 30 \text{ V}, T_j = 125^\circ\text{C}, (\text{E open})$	I_{CBO} I_{CBO}	– –	– –	15 nA 5 μA
Emitter-Base cutoff current				
$V_{EB} = 5 \text{ V}, (\text{C open})$	I_{EBO}	–	–	100 nA
Gain-Bandwidth Product – Transitfrequenz				
$V_{CE} = 5 \text{ V}, I_C = 10 \text{ mA}, f = 100 \text{ MHz}$	f_T	–	300 MHz	–
Collector-Base Capacitance – Kollektor-Basis-Kapazität				
$V_{CB} = 10 \text{ V}, I_E = i_e = 0, f = 1 \text{ MHz}$	C_{CBO}	–	3.5 pF	6 pF
Emitter-Base Capacitance – Emitter-Basis-Kapazität				
$V_{EB} = 0.5 \text{ V}, I_C = i_c = 0, f = 1 \text{ MHz}$	C_{EBO}	–	9 pF	–
Thermal resistance junction to ambient air Wärmewiderstand Sperrsicht – umgebende Luft	R_{thA}	< 420 K/W ¹⁾		
Recommended complementary PNP transistors Empfohlene komplementäre PNP-Transistoren		BC856 ... BC860		
Marking of available current gain groups Stempelung der lieferbaren Stromverstärkungsgruppen	BC846A = 1A BC846B = 1B	BC847A = 1E BC847B = 1F BC847C = 1G BC850B = 1F BC850C = 1G	BC848A = 1E BC848B = 1F BC848C = 1G BC849B = 1F BC849C = 1G	

2 Tested with pulses $t_p = 300 \mu\text{s}$, duty cycle $\leq 2\%$ – Gemessen mit Impulsen $t_p = 300 \mu\text{s}$, Schaltverhältnis $\leq 2\%$

1 Mounted on P.C. board with 3 mm^2 copper pad at each terminal
Montage auf Leiterplatte mit 3 mm^2 Kupferbelag (Lötpad) an jedem Anschluss